Application/Control No. Applicant(s)/Patent Under Reexamination 10/574,974 ORON ET AL. Notice of References Cited Examiner **Art Unit** Page 1 of 1 Quyen P. Leung 2874 **U.S. PATENT DOCUMENTS Document Number** Date Country Code-Number-Kind Code Name Classification MM-YYYY US-7,099,552 08-2006 Oron et al. Α 385/139 US-5,534,000 В 07-1996 Bruce, Johnny M. 606/15 * US-5,530,780 С 06-1996 Ohsawa, Masami 385/31 US-2005/0135772 D 06-2005 Nield et al. 385/140 US-Ε US-F US-G US-Н US--US-J US-K US-1 US-М FOREIGN PATENT DOCUMENTS **Document Number** Date Country Name Country Code-Number-Kind Code MM-YYYY Classification EP 399660 A1 11-1990 Ν **European Patent** DAIGNAULT et al. 0 Р Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U DEFINITION OF SCATTERING, WORDNET.PRINCETON.EDU/PERLWEBWN, PRINTED 6/27/07 DEFINITION OF DIFFUSION, EN.WIKIPEDIA.ORG/WIKI/DIFFUSION, PRINTED 6/27/07

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